



SFW

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Peter J. de Groot
Serial No. : 10/659,060
Filed : September 9, 2003
Title : INTERFEROMETRY METHOD FOR ELLIPSOMETRY, REFLECTOMETRY,
AND SCATTEROMETRY MEASUREMENTS, INCLUDING
CHARACTERIZATION OF THIN FILM STRUCTURES

Art Unit : 2877
Examiner : Marissa Detschel

Mail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

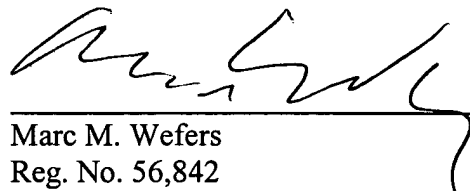
PETITION FOR ONE-MONTH EXTENSION OF TIME

Pursuant to 37 CFR §1.136, applicant hereby petitions that the period for response to the action dated September 27, 2005, be extended for one month to and including January 27, 2006.

Enclosed is a check for \$120 for the required fee. Please apply any other charges or credits to Deposit Account No. 06-1050, referencing 09712-332001.

Respectfully submitted,

Date: 1/27/06


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CERTIFICATE OF MAILING BY FIRST CLASS MAIL

I hereby certify under 37 CFR §1.8(a) that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage on the date indicated below and is addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

January 27, 2006
Date of Deposit
Diane M. Saturno
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Typed or Printed Name of Person Signing Certificate